Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/001,721	SIMPSON ET AL.
Examiner	Art Unit
Djenane M. Bayard	2141

	SEAR	CHED	
Class	Subclass	Date	Examiner
399	87	10/31/2006	DB
718	102	10/31/2006	DB

INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
east	10/31/2006	db
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